

The logo for the Embedded Vision Summit 2018 is displayed against a blue background with a subtle globe-like pattern. The word "embedded" is in a white, lowercase, sans-serif font. Below it, "VISION" is in a larger, bold, white, uppercase, sans-serif font, with the letter "O" replaced by a colorful circular graphic divided into segments of yellow, red, blue, and green. Underneath "VISION" is the word "SUMMIT" in a white, uppercase, sans-serif font, and at the bottom is the year "2018" in a white, lowercase, sans-serif font.

embedded VISION SUMMIT 2018

Optimize Performance:

Start your algorithm development with the imaging subsystem

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May 2018

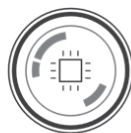
twisthink



Leading business through the art + science of what's next



Human Centered Design



Embedded Vision



AI



Connectivity

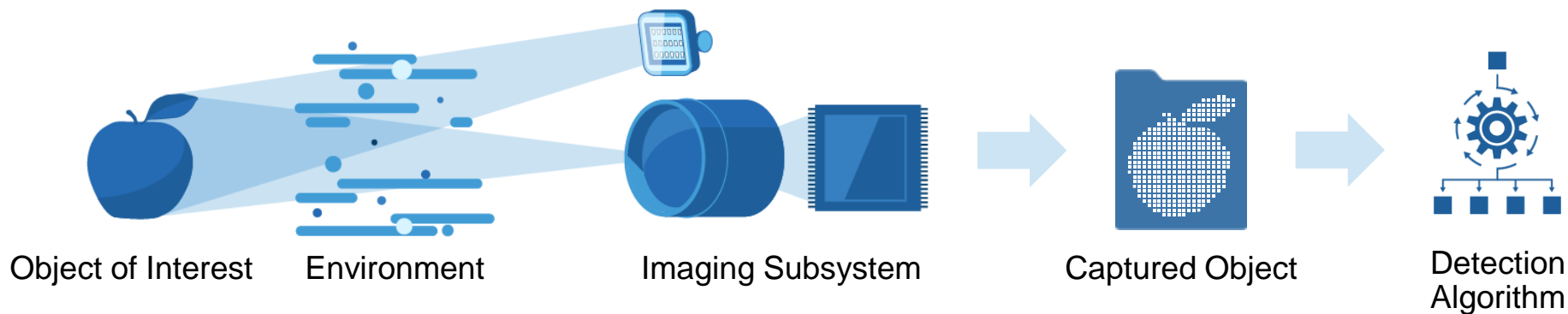


Internet of Things



UI / UX

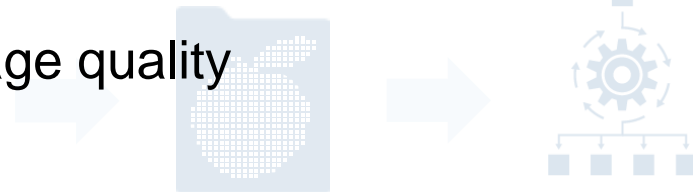
Start your algorithm development with the imaging subsystem



Start your algorithm development with the imaging subsystem

Why?

- Algorithm performance is limited by image quality
- Imaging subsystems are complex





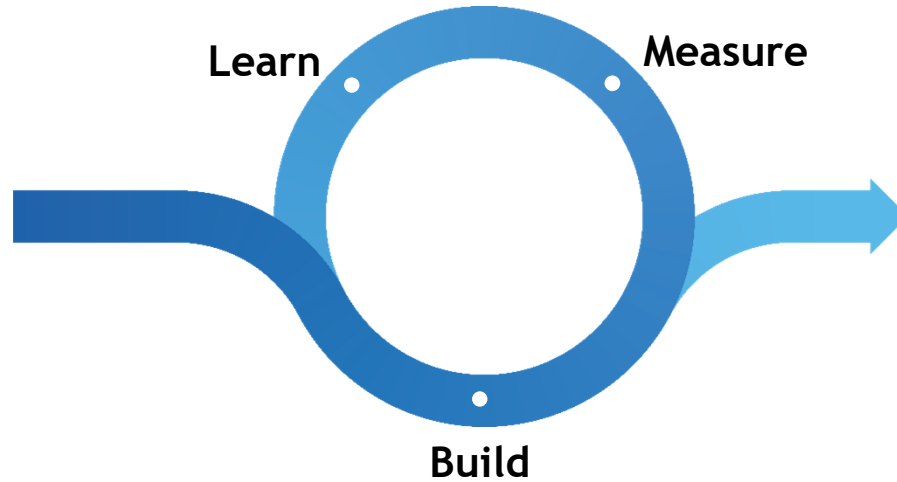
Start your algorithm development with the imaging subsystem



Iteration

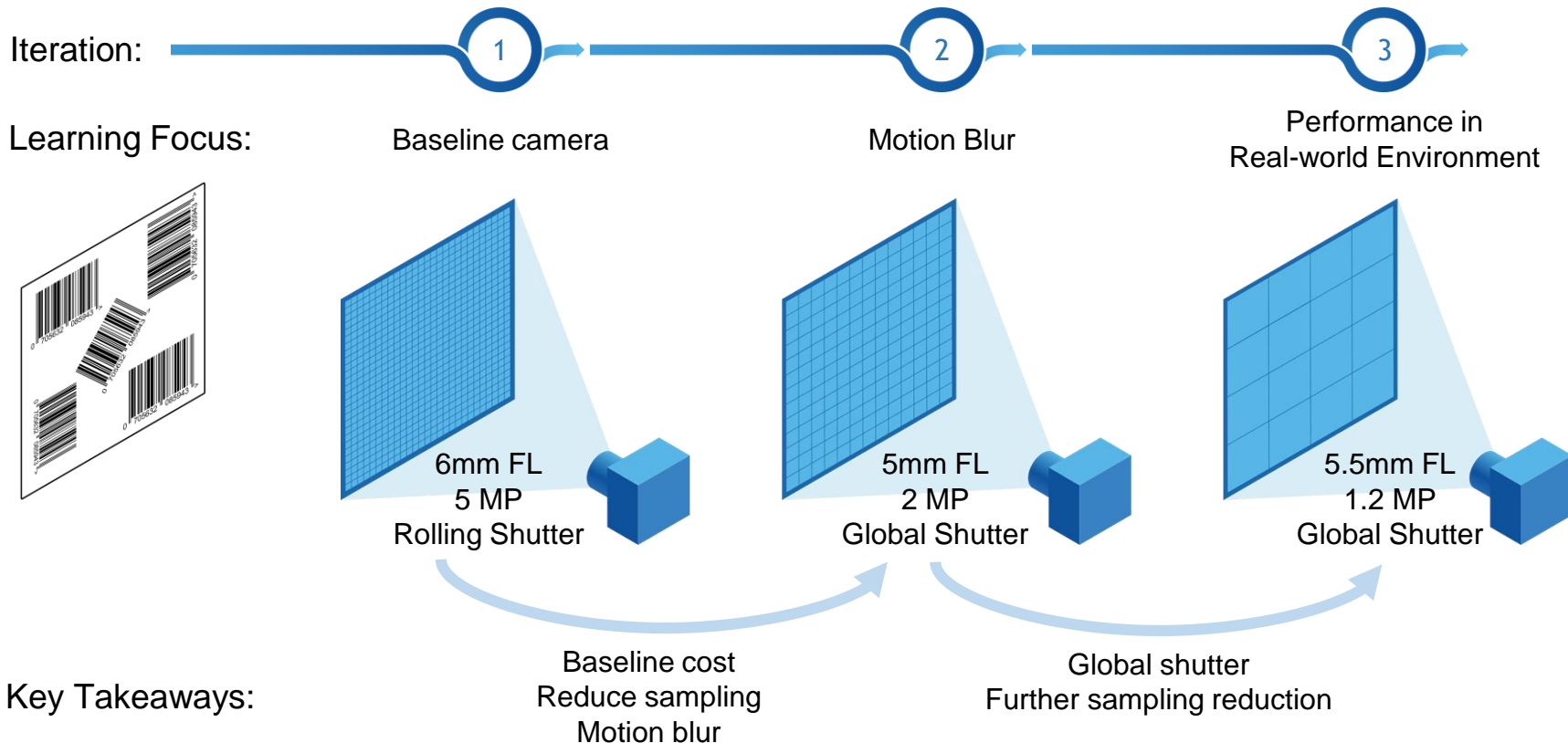
Sampling and Sharpness

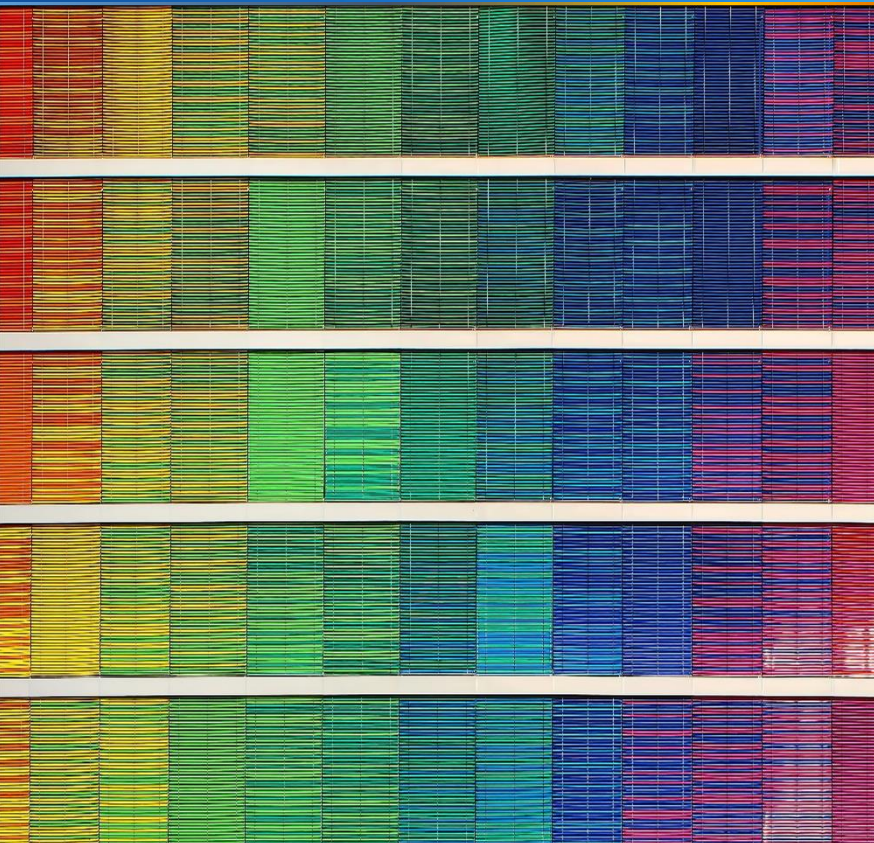
Evaluation



Build-Measure-Learn: A flexible framework for focused learning
Iteration leads to an optimized solution

Linear Barcode Reader Example





Start your algorithm development with the imaging subsystem

Iteration



Sampling and Sharpness

Evaluation

Sampling is pixel count over a given area (e.g. pixels per inch)

Insufficient sampling reduces discriminating detail



Sampling Requirements:

- Physical size of distinguishing features
- Max detection distance
- Start with 4-5 pixels across key features

Sampling: Image Subsystem Parameters

Use a camera model to quickly evaluate sampling

Inputs

Image Sensor

Horizontal Pixel Count	2592	Horizontal Dimension (mm)	5.70	Sensor Spatial Resolution (lp/mm)	227.27
Vertical Pixel Count	1944	Vertical Dimension (mm)	4.28		
Pixel Size (um)	2.2	Diagonal Dimension (mm)	7.13		
		Optical Format (in)	0.42		

Lens

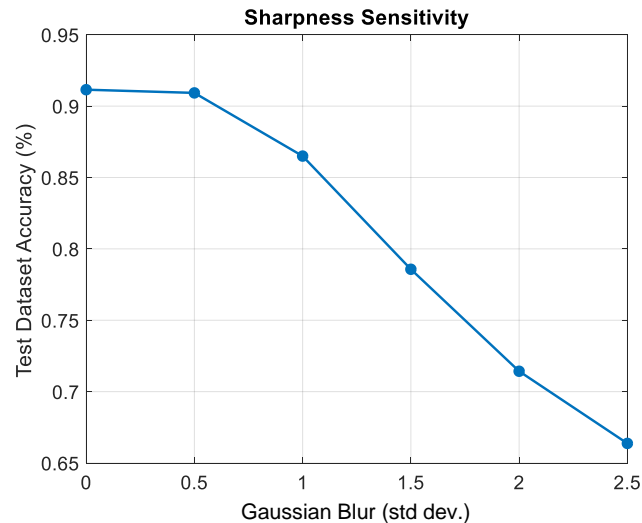
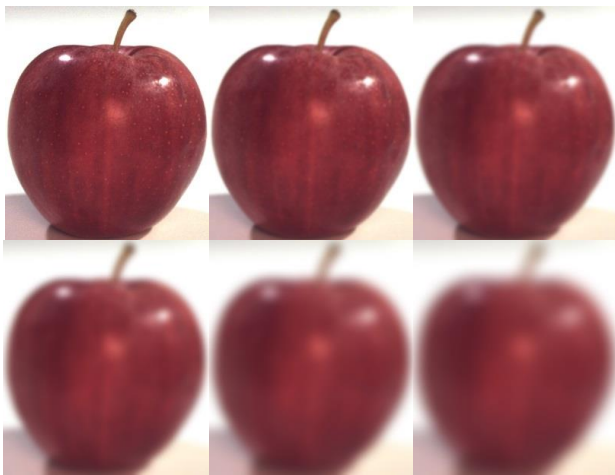
Focal Length (mm)	2.2	Horizontal FOV (degrees)	104.69	Note: FOV as focused at infinity	
F/#	2	Vertical FOV (degrees)	88.37		
Circle of Confusion (mm)	0.00334	Diagonal FOV (degrees)	116.63	Near Sampling (px per mm)	6.137013
Focus Distance (mm)	213.25	Hyperfocal Distance (mm)	726.75	Far Sampling (px per mm)	3.347883
		Near DOF (mm)	165.15	Near Magnification	0.013501
		Far DOF (mm)	300.90	Far Magnification	0.007365
		DOF Working Distance (mm)	135.75		

Download Twisthink worksheet at: www.twisthink.com/embedded-vision-summit

Sharpness is a measure of spatial frequency

Blur reduces high-frequency content and discriminating detail

Use a sensitivity study to understand sharpness requirements



Static



Environment

Fog, particulate, lens surface contaminate, ...

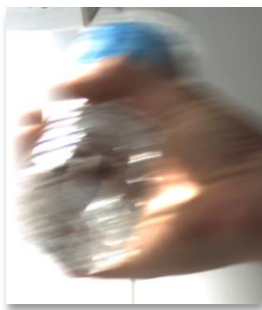
Lens

Temperature, mfg. variation, ...

Image Sensor

Varies with wavelength

Dynamic

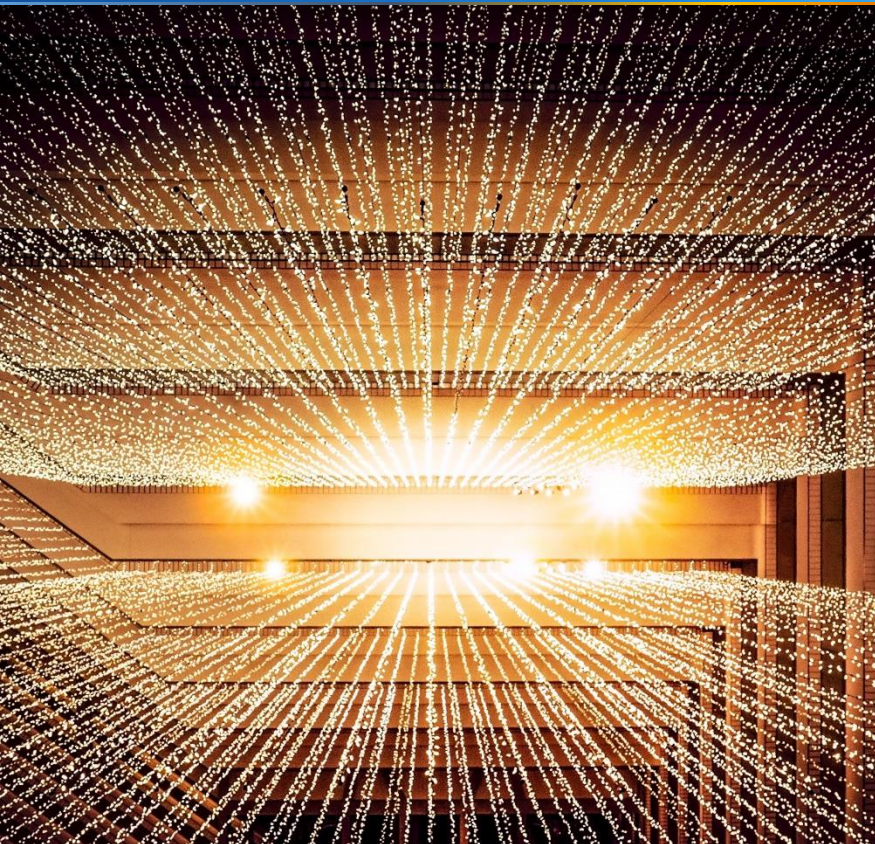


Motion speed

Limit speed, limit exposure

Exposure duration

Affects image brightness, lighting intensity, ...



Start your algorithm development with the imaging subsystem

Iteration

Sampling and Sharpness

► Evaluation

Algorithm Development Framework

Imaging Subsystem



Dataset Collection

Representative Environment

Capture Tool

Dataset



Ground Truthing

Human Interpretation

Ground Truth Tool

Dataset with Ground Truth



Algorithm Development

Algorithm Development Environment

Detection Algorithm



Performance Evaluation

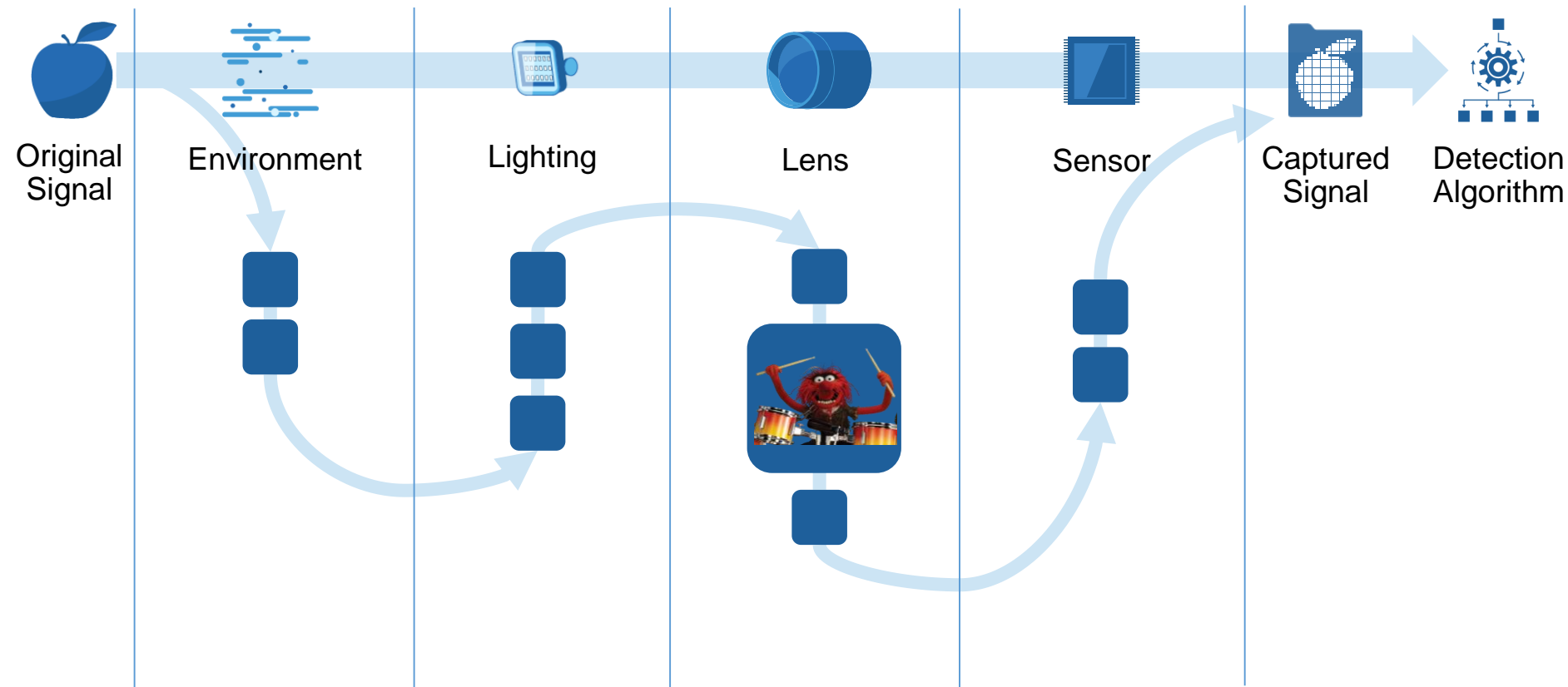
Performance Metric Definition

Grading Tool

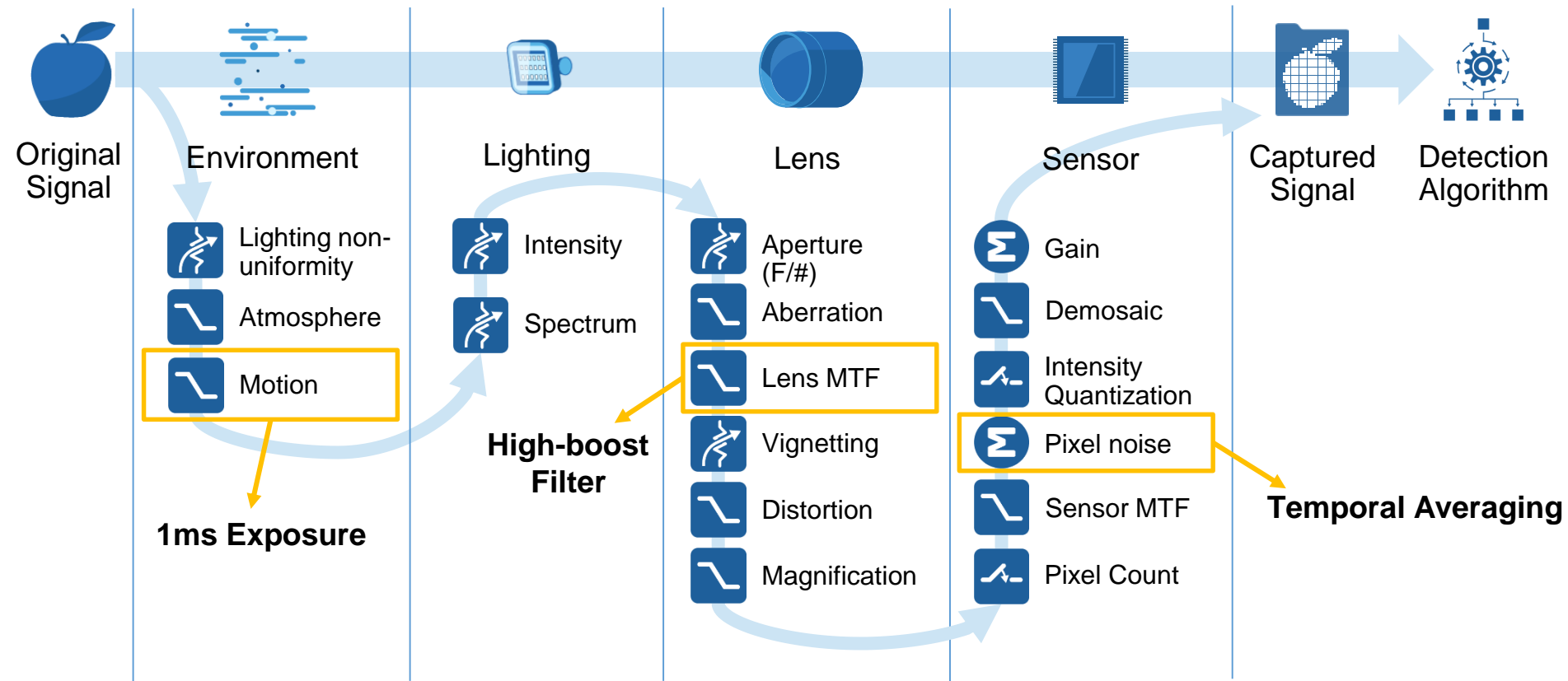
Grade Report



Modeling Signal Path



Modeling Signal Path



Start your algorithm development with the imaging subsystem

Iteration ➡ Be focused and intentional
Find the right solution

Sampling and Sharpness ➡ High-impact image quality factors
Focus here first

Evaluation ➡ Use datasets and modeling
Evaluate often

[Edmund Optics MTF Intro](#)

[Measuring Sharpness](#)

Slanted Edge: International Standard ISO 12233:2000(E)

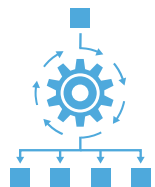
www.twisthink.com/embedded-vision-summit

- Download Presentation
- Download Twisthink Sampling Worksheet

Finding the Right Solution



Imaging
Subsystem



Detection
Algorithm

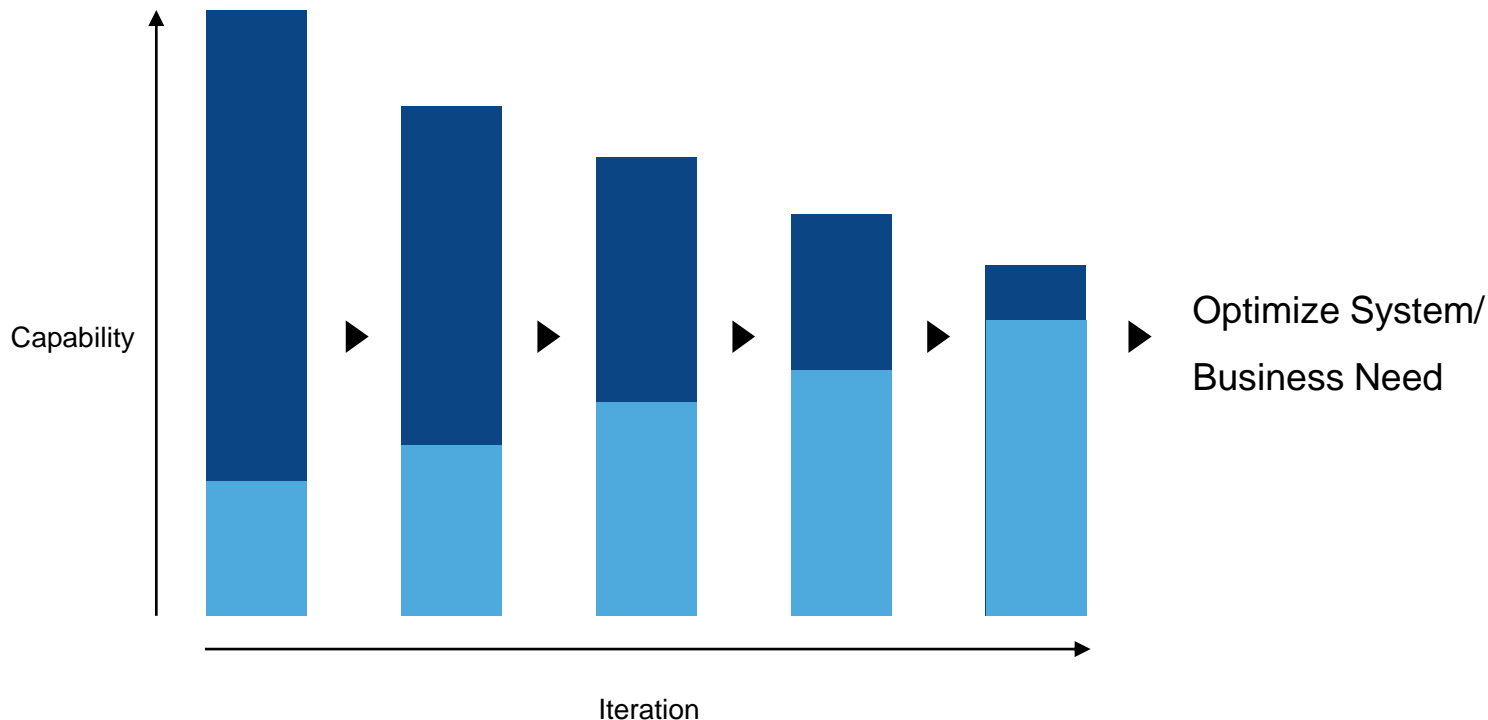


Image Subsystem “Noise Sources”

Noise Source	Image Degradation	Improvement Options
Insufficient sampling	Loss of spatial information, aliasing artifacts (Moiré patterns, staircasing)	Higher resolution sensor, increased magnification, anti-aliasing filters
Blur	Removal of high frequency content, Reduction in discriminating detail	Increased lens quality, sharpening algorithms
Low Signal Amplitude	Reduced signal-to-noise ratio (SNR)	Increased exposure time/gain, increased light source intensity, improved sensor sensitivity
Image Noise	Additive random unwanted signal, Reduced signal-to-noise ratio (SNR)	Minimize gain, filtering, temporal averaging, increased contrast, improved pixel design
False contouring (low gray-level quantization)	Dull and washed out gray look, saturated or undersaturated signal	Increased quantizer levels, high dynamic range sensor
Color Inaccuracy	Loss of discriminating color information	Auto white balance, color calibration
<i>And others...</i>		

Sharpness: Neglecting Effect of Temperature

